

Search Notes



Application No.

10/625,691

Examiner

Linh V Nguyen

Applicant(s)

OHASHI ET AL.

Art Unit

2819

SEARCHED

Class	Subclass	Date	Examiner
341	118	↗	
	120		
	143		
	144	6/16/04	L

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
341	143	6/16/04	L
341	144	6/16/04	L

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
low-pass, filter first and second cutoff frequency.	6/16/04	L